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# -100V P-Channe Enhancement Mode Power MOSFET



## Description

The XPX10P08RD uses advanced trench technology to provide excellent  $R_{DS(ON)}$ , low gate charge and operation with gate voltages as low as 4.5V. This device is suitable for use as a Battery protection or in other Switching application.

## **General Features**

V<sub>DS</sub> = -100V I<sub>D</sub> =-80A

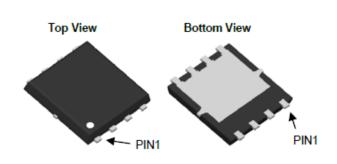
 $R_{DS(ON)}$  <18m $\Omega$  @ V<sub>GS</sub>=10V

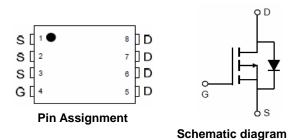
## Application

Brushless motor

Load switch

Uninterruptible power supply





## Package Marking and Ordering Information

Product ID	Pack	Marking	Qty(PCS)				
XPX10P08RD	PDFN5*6-8L	XPX10P08RD XXX YYYY	5000				
Absolute Maximum Ratings (T <sub>c</sub> =25 <sup>°</sup> C unless otherwise noted)							
Symbol	Parameter	Rating	Units				
Vds	Drain-Source Voltage	-100	V				
Vgs	Gate-Source Voltage	±20	V				
I₀@Tc=25°C	Continuous Drain Current, V <sub>GS</sub> @ -10V <sup>1</sup>	-80	А				
I <sub>D</sub> @T <sub>C</sub> =100°C	Continuous Drain Current, V <sub>GS</sub> @ -10V <sup>1</sup>	-56	А				
Ідм	Pulsed Drain Current <sup>2</sup>	-300	А				
EAS	Single Pulse Avalanche Energy <sup>3</sup>	174	mJ				
las	Avalanche Current	-50	А				
P <sub>D</sub> @T <sub>C</sub> =25°C	Total Power Dissipation <sup>4</sup>	280	W				
Тѕтс	Storage Temperature Range	-55 to 150	°C				
TJ	Operating Junction Temperature Range	-55 to 150	°C				
R <sub>θ</sub> JA	Thermal Resistance Junction-Ambient <sup>1</sup>	25	°C/W				
Rejc	Thermal Resistance Junction-Case <sup>1</sup>	0.65	°C/W				



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## P-Channel Electrical Characteristics (TJ =25 °C, unless otherwise noted)

Symbol	Parameter	Test Condition	Min.	Тур.	Max.	Units
V(BR)DSS	Drain-Source Breakdown Voltage	V <sub>GS</sub> =0V, I <sub>D</sub> =-250µA	-100	110	-	V
IDSS	Zero Gate Voltage Drain Current	V <sub>DS</sub> =-100V, V <sub>GS</sub> =0V,	-	-	-1.0	μA
IGSS	Gate to Body Leakage Current	V <sub>DS</sub> =0V, V <sub>GS</sub> = ±20V	-	-	±100	nA
VGS(th)	Gate Threshold Voltage	V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =-250µA	-1.0	-1.6	-2.5	V
RDS(on)	Static Drain-Source on-Resistance	V <sub>GS</sub> =-10V, I <sub>D</sub> =-20A	-	18	25	
		V <sub>GS</sub> =-4.5V, I <sub>D</sub> =-10A	-	21	30	mΩ
Ciss	Input Capacitance		-	4228	-	pF
Coss	Output Capacitance	V <sub>DS</sub> =-50V, V <sub>GS</sub> =0V, f=1.0MHz	-	388	-	pF
Crss	Reverse Transfer Capacitance	1 1.00012	-	27	-	pF
Qg	Total Gate Charge		-	80	-	nC
Qgs	Gate-Source Charge	V <sub>DS</sub> =-50V, I <sub>D</sub> =-5A, V <sub>GS</sub> =-10V	-	15.6	-	nC
Qgd	Gate-Drain("Miller") Charge	V8310V	-	17.2	-	nC
td(on)	Turn-on Delay Time		-	26	-	ns
tr	Turn-on Rise Time	V <sub>DD</sub> =-50V, I <sub>D</sub> =-5A,	-	78	-	ns
td(off)	Turn-off Delay Time	R <sub>G</sub> =6Ω, V <sub>GS</sub> =-10V	-	200	-	ns
t <sub>f</sub>	Turn-off Fall Time		-	210	-	ns
IS	Maximum Continuous Drain to Source Diode Forward Current		-	-	-80	А
ISM	Maximum Pulsed Drain to Source Diode Forward Current		-	-	-280	А
VSD	Drain to Source Diode Forward Voltage	V <sub>GS</sub> =0V, I <sub>S</sub> =-30A	-	-	-1.2	V
trr	Body Diode Reverse Recovery Time	Tյ=25℃,	-	208	-	ns
Q <sub>rr</sub>	Body Diode Reverse Recovery Charge	l⊧=-5A,dI/dt=100A/µs	-	560	-	nC

Note :

1. The data tested by surface mounted on a 1 inch 2 FR-4 board with 2OZ copper.

2、The data tested by pulsed , pulse width  $\leq$  300us , duty cycle  $\leq$  2%

3、The EAS data shows Max. rating . The test condition is V DD =-72V,VGS =-10V,L=0.1mH,IAS =-50A

4. The power dissipation is limited by 150  $^\circ\!\!\mathbb{C}$  junction temperature

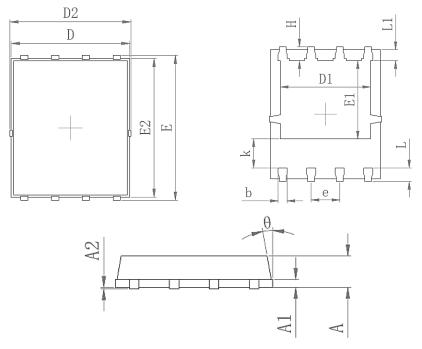
5. The data is theoretically the same as I D and I DM , in real applications , should be limited by total power dissipation.



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# Package Mechanical Data-PDFN5X6-8L-XZT Single



	Common mm			
Symbol				
	Mim	Max		
A	0.90	1.10		
A1	0.254	0.254 REF		
A2	0-0	0-0.05		
D	4.824	4.976		
D1	3.910	4.110		
D2	4.944	5.076		
E	5.924	6.076		
E1	3.375	3.575		
E2	5.674	5.826		
b	0.350	0.450		
е	1.2	1.270		
L	0.534	0.686		
L1	0.424	0.576		
К	1.190	1.390		
Н	0.549	0.701		
Φ	<b>8</b> °	12°		



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#### Flow (wave) soldering (solder dipping)

Product	Peak Temperature	Dipping Time
Pb device	<b>245℃±5</b> ℃	5sec±1sec
Pb-Free device	<b>260</b> ℃+0/-5℃	5sec±1sec



This integrated circuit can be damaged by ESD UniverChip Corporation recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedure can cause damage. ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

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